

<b>Notice of References Cited</b>	Application/Control No. 10/522,365	Applicant(s)/Patent Under Reexamination QUIRION ET AL.	
	Examiner Ganapathy Krishnan	Art Unit 1623	Page 1 of 2

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	V	Wong et al(Bioorganic & Medicinal Chemistry Letters, 1998, 8, 2333-2338
	W	Lerner et al J. Org. Chem. 1979, 44(19), 3368-3373
	X	Furstner Synthesis, 1989, 571-590

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	Examiner Ganapathy Krishnan	Art Unit 1623	Page 2 of 2

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